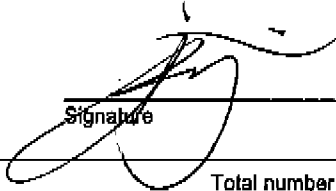


Substitute Form PTO-1595
Attorney Docket No.: 15934-003001

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Commissioner for Patents: Please record the attached original document(s) or copy(ies).			
1. Name of conveying party(ies): <p style="text-align: center;">Kuniaki Nagayama</p> <p style="text-align: center;">Additional name(s) attached? <input type="checkbox"/> Yes <input checked="" type="checkbox"/> No</p>	2. Name and address of receiving party(ies): <p style="text-align: center;">Nagayama IP Holdings LLC 145 West 57th Street, 21st Floor New York, NY 10019</p> <p style="text-align: center;">Additional names/addresses attached? <input type="checkbox"/> Yes <input checked="" type="checkbox"/> No</p>		
3. Nature of conveyance: <input checked="" type="checkbox"/> Assignment <input type="checkbox"/> Merger <input type="checkbox"/> Security Agreement <input type="checkbox"/> Change of Name <input type="checkbox"/> Other: Execution Date: March 1, 2006	4. Application number(s) or patent number(s): <p>If this document is being filed with a new application, the execution date of the application is:</p> <table style="width: 100%;"> <tr> <td style="width: 50%;"> A. Patent Application No(s): <p style="text-align: center;">10/424,682 11/130,801</p> </td> <td style="width: 50%;"> B. Patent No(s): </td> </tr> </table> <p style="text-align: center;">Additional numbers attached? <input type="checkbox"/> Yes <input checked="" type="checkbox"/> No</p>	A. Patent Application No(s): <p style="text-align: center;">10/424,682 11/130,801</p>	B. Patent No(s):
A. Patent Application No(s): <p style="text-align: center;">10/424,682 11/130,801</p>	B. Patent No(s): 		
5. Name/address of party to whom correspondence concerning document should be mailed: <p style="text-align: center;">ANITA L. MEIKLEJOHN, PH.D. Fish & Richardson P.C. 225 Franklin Street Boston, MA 02110</p>	6. Total number of applications/patents involved: 1 7. Total fee (37 CFR §3.41): \$80 <input type="checkbox"/> Enclosed <input checked="" type="checkbox"/> Authorized to charge Deposit Account. 8. Deposit Account No.: 06-1050 <p style="text-align: center;">Please apply any additional charges, or any credits, to our Deposit Account No. 06-1050.</p>		
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Anita L. Meiklejohn, Ph.D. <u>Reg. No. 35,283</u> Name of Person Signing	<div style="text-align: center;">  Signature </div> <div style="text-align: center;"> <u>25 July 2006</u> Date </div>		
Total number of pages including coversheet, attachments and document: 4			

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CERTIFICATE OF TRANSMISSION BY FACSIMILE

I hereby certify that this correspondence is being transmitted by facsimile to the Patent and Trademark Office on the date indicated below.

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Signature

Carrie A. Amonte
Typed Name of Person Signing Certificate

PATENT

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Assignment from Kunlaki Nagayama to Nagayama IP Holdings, LLC
Page 1 of 3

ASSIGNMENT

For valuable consideration, I, Kunizaki Nagayama of 2-5-1-13, Tatsumi-minami, Okazai,
Aichi Prefecture 444-0674, JAPAN, hereby assign to:

Nagayama IP Holdings, LLC

a corporation of Delaware having a place of business at:

145 West 57th Street, 21st Floor
New York, NY 10019
United States of America

and its successors and assigns (collectively hereinafter called "the Assignee"), my entire right,
title and interest throughout the world in the inventions and improvements which are subject of:

(1) Japanese Patent Application No. JP 2000-351844, filed on November 17, 2000 and
titled: METHOD FOR DETERMINING BASE SEQUENCE OF DNA OR RNA AND DNA
SEQUENCER;

(2) Japanese Patent Application No. JP Heisei10-373597, filed on December 28, 1998
and titled: DETECTION METHODS OF COMPLEX SIGNALS, COMPLEX MICROSCOPE
AND COMPLEX DIFFRACTOMETER;

(3) Japanese Patent Application No. JP 2000-085493, filed on March 27, 2000 titled
THIN FILM PHASE PLATE FOR PHASE DIFFERENCE ELECTRON MICROSCOPE, THE
PHASE DIFFERENCE ELECTRON MICROSCOPE, AND AN ANTISTATIC METHOD FOR
THE PHASE PLATE;

(4) Japanese Patent Application No. JP 2001-033799, filed on February 9, 2001 and
titled: PHASE PLATE LENS SYSTEM FOR TRANSMISSION ELECTRON MICROSCOPE
AND TRANSMISSION ELECTRON MICROSCOPE;

(5) Japanese Patent Application No. JP 2001-290860, filed on September 25, 2001 and
titled: DIFFERENTIAL CONTRAST ELECTRON MICROSCOPE AND METHOD OF DATA
PROCESSING OF ELECTRON MICROSCOPE IMAGE;

(6) Japanese Patent Application No. 2004-351902, filed on December 3, 2004 and titled:
PHASE PLATES FOR PHASE CONTRAST ELECTRON MICROSCOPE AND
FABRICATION METHODS OF PHASE PLATES;

(7) Japanese Patent Application No. 2005-321402, filed on November 4, 2005 and titled:
PHASE PLATES FOR PHASE CONTRAST MICROSCOPE AND FABRICATION
METHODS OF PHASE PLATES;

Assignment from Kuniaki Nagayama to Nagayama IP Holdings, LLC
Page 2 of 3

(8) Japanese Patent Application No. 2005-330374, filed on November 15, 2005 and titled: PHASE CONTRAST ELECTRON MICROSCOPE APPARATUS;

(9) United States Patent Application No. 09/992,538, filed on November 19, 2001 and titled: METHOD OF DETERMINING BASE SEQUENCE OF DNA OR RNA AND DNA SEQUENCER;

(10) United States Patent Application No. 11/130,801, filed on May 17, 2005 and titled: METHOD OF DETERMINING BASE SEQUENCE OF DNA OR RNA AND DNA SEQUENCER;

(11) United States Patent Application No. 10/424,682, filed on April 28, 2003 and titled: METHOD OF DETERMINING BASE SEQUENCE OF DNA OR RNA AND DNA SEQUENCER;

(12) United States Patent No. 6,674,078, issued January 6, 2004 and titled: DIFFERENTIAL CONTRAST TRANSMISSION ELECTRON MICROSCOPE AND METHOD OF PROCESSING DATA ABOUT ELECTRON MICROSCOPE IMAGES; and

(13) PCT Application PCT/US2005/0037, filed February 7, 2005 and titled: COMPLEX POINTILLISTIC MULTICOLOR PRINTING

This assignment includes the aforementioned applications and patents, any and all United States patents and patents in all other countries, utility models, and design registrations granted for any of said inventions or improvements, and the right to claim priority based on the filing date of said applications and patents under the International Convention for the Protection of Industrial Property, the Patent Cooperation Treaty, the European Patent Convention, and all other treaties of like purposes; and we authorize the Assignee to apply in all countries in our name or in its own name for patents, utility models, design registrations and like rights of exclusion and for inventors' certificates for said inventions and improvements; and I agree for myself and my heirs, legal representatives and assigns, without further compensation to perform such lawful acts and to sign such further applications, assignments, Preliminary Statements and other lawful documents as the Assignee may reasonably request to effectuate fully this assignment.

IN WITNESS WHEREOF, I hereto set my hand and seal at 5-1 Higashiyama, Miyoda-ji
this 1st day of March, 2006 Obasabō 444-8787, Aichi, Japan

永山 國雄

Kuniaki Nagayama

WITNESSED: [Signature] DATE: March, 1st, 2006

WITNESSED: 喜多山 篤 DATE: March, 1st, 2006

JEOL Ltd co-owns:

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7/12/2006

Assignment from Kuniaki Nagayama to Nagayama IP Holdings, LLC
Page 3 of 3

(1) Japanese Patent Application No. JP 2000-085493, filed on March 27, 2000 titled
THIN FILM PHASE PLATE FOR PHASE DIFFERENCE ELECTRON MICROSCOPE, THE
PHASE DIFFERENCE ELECTRON MICROSCOPE, AND AN ANTISTATIC METHOD FOR
THE PHASE PLATE;

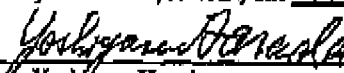
(2) Japanese Patent Application No. JP 2001-033799, filed on February 9, 2001 and
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(4) United States Patent No. 6,674,078, issued January 6, 2004 and titled:
DIFFERENTIAL CONTRAST TRANSMISSION ELECTRON MICROSCOPE AND
METHOD OF PROCESSING DATA ABOUT ELECTRON MICROSCOPE IMAGES;

with Kuniaki Nagayama and consents to Kuniaki Nagayama's foregoing assignment of his rights
in these applications to Nagayama IP Holdings, LLC.

IN WITNESS WHEREOF, I hereto set my hand and seal at 1-2, Musashino 3-chome,
Akishima, Tokyo 196-8538, JAPAN, this 14th day of February, 2006


Name: Yoshiyasu Harada
Title: President
JEOL Ltd.

WITNESSED:  DATE: February 14, 2006

WITNESSED: S. Chiba DATE: February 14, 2006

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